

Report No.: SEWM2305000159RG01

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TEST REPORT

Application No.: SEWM2305000159RG

Applicant: Quectel Wireless Solutions Co., Ltd.

Address of Applicant:

Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin Road,

Michael Bistoirt Changhai China 202222

Minhang District, Shanghai, China 200233

Manufacturer: Quectel Wireless Solutions Co., Ltd.

Address of Manufacturer: Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin Road,

Minhang District, Shanghai, China 200233

EUT Description: LTE Cat 1 bis Module

Model No.: EG915Q-NA

Trade Mark: Quectel

FCC ID: XMR2023EG915QNA

47 CFR Part 2

Standards: 47 CFR Part 22

47 CFR Part 24 47 CFR Part 27

Date of Receipt: 2023/03/01

Date of Test: 2023/03/01 to 2023/03/16 (for original report SEWA2212000096RG01)

Date of Issue: 2023/05/08

Test Result : PASS *

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature :

That a Sun

Panta Sun

Wireless Laboratory Manager



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1 Version

		Revision Record		
Version	Chapter	Date	Modifier	Remark
01		2023/05/08		Original

King-P Li
(King-p Li) / Test Engineer
(Well Wei) / Reviewer



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2 Test Summary

2.1 LTE Band 5

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913(a)(5)	ERP ≤ 7 W	Section 1 of Appendix B.3	Pass
Peak-Average Ratio	§22.913(d)	Limit≤13 dB	Section 2 of Appendix B.3	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B.3	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B.3	Pass
Band Edges Compliance	§2.1051, §22.917(a)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B.3	Pass
Spurious Emission at Antenna Terminals	§2.1051, §22.917(a)	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B.3	Pass
Field Strength of Spurious Radiation	§2.1053, §22.917(a)	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B.3	Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §22.355	≤ ±2.5ppm.	Section 8 of Appendix B.3	Pass



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2.2 LTE Band 2

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232(c)	EIRP ≤ 2 W	Section 1 of Appendix B.1	Pass
Peak-Average Ratio	§24.232(d)	Limit≤13 dB	Section 2 of Appendix B.1	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B.1	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B.1	Pass
Band Edges Compliance	§2.1051, §24.238(a)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B.1	Pass
Spurious Emission at Antenna Terminals	§2.1051, §24.238(a)	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B.1	Pass
Field Strength of Spurious Radiation	§2.1053, §24.238(a)	≤ -13 dBm/1 MHz.	Section 7 of Appendix B.1	Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §24.235	Within authorized bands of operation/frequency block.	Section 8 of Appendix B.1	Pass



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2.3 LTE Band 4 /66

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(d)(4)	EIRP ≤ 1 W	Section 1 of Appendix B.2&B.6	Pass
Peak-Average Ratio	§27.50(d)(5)	Limit≤13 dB	Section 2 of Appendix B.2&B.6	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B.2&B.6	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B.2&B.6	Pass
Band Edges Compliance	§2.1051, §27.53(h)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B.2&B.6	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(h)	≤ -13 dBm/1 MHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B.2&B.6	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(h)	≤ -13 dBm/1 MHz.	Section 7 of Appendix B.2&B.6	Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B.2&B.6	Pass



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2.4 LTE Band 12

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046 §27.50(c)(10)	ERP≤3W.	Section 1 of Appendix B.4	Pass
Peak-Average Ratio		Limit≤13 dB	Section 2 of Appendix B.4	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B.4	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B.4	Pass
Band Edges Compliance	§2.1051, §27.53(g)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B.4	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(g)	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B.4	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(g)	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B.4	Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B.4	Pass



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2.5 LTE Band 13

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(b)(10)	ERP ≤ 3 W.	Section 1 of Appendix B.5	Pass
Peak-Average Ratio		Limit≤13 dB	Section 2 of Appendix B.5	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B.5	Pass
Bandwidth	§2.1049,	OBW: No limit. EBW: No limit.	Section 4 of Appendix B.5	Pass
Band Edges Compliance	§2.1051, §27.53(c)	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B.5	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(c) §27.53(f)	≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges. On all frequencies between 763–775 MHz and 793–805 MHz, by a factor not less than 65 + 10 log (P) dB in a 6.25 kHz band segment, for mobile and portable stations. For operations in the 746-758 MHz, 775-788 MHz, and 805-806 MHz bands, emissions in the band 1559-1610 MHz shall be limited to −70 dBW/MHz equivalent isotropically radiated power (EIRP) for wideband signals, and −80 dBW EIRP for discrete emissions of less than 700 Hz bandwidth.	Section 6 of Appendix B.5	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(c) §27.53(f)	FCC: ≤ -13 dBm/100 kHz. For operations in the 746-758 MHz, 775-788 MHz, and 805-806 MHz bands, emissions in the band 1559-1610 MHz shall be limited to −70 dBW/MHz equivalent isotropically radiated power (EIRP) for wideband signals, and −80 dBW EIRP for discrete emissions of less than 700 Hz bandwidth.	Section 7 of Appendix B.5	Pass
Frequency Stability	§2.1055(a)(1)(b) §2.1055(d)(1) §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B.5	Pass



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Remark:

This test report (Report No.: SEWM2305000159RG01 issue on 2023/05/08) is based on the original test report (Report No.: SEWA2212000096RG01 issue on 2023/03/17).

Review this report and original report, this report just changing the parts according to the declaration letter from client

Therefore in this report all items do not need to retest and all test data in this report are based on the previous report with report number SEWA2212000096RG01 issue on 2023/03/17.



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3 General Information

3.1 Details of Client

Applicant:	Quectel Wireless Solutions Co., Ltd.
Address of Applicant:	Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin Road, Minhang District, Shanghai, China 200233
Manufacturer:	Quectel Wireless Solutions Co., Ltd.
Address of Manufacturer:	Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin Road, Minhang District, Shanghai, China 200233

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services (Suzhou) Co., Ltd.
Address:	South of No. 6 Plant, No. 1, Runsheng Road, Suzhou Industrial Park, Suzhou Area, China (Jiangsu) Pilot Free Trade Zone
Post code:	215000
Test engineer:	King-p Li

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• A2LA (Certificate No. 6336.01)

SGS-CSTC STANDARDS TECHNICAL SERVICES (SUZHOU) CO., LTD. is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 6336.01.

• Innovation, Science and Economic Development Canada

SGS-CSTC STANDARDS TECHNICAL SERVICES (SUZHOU) CO., LTD. has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0120.

IC#: 27594.

• FCC -Designation Number: CN1312

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Test Firm Registration Number: 717327



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3.4 General Description of EUT

EUT Description:	LTE Cat 1 bis Modu	LTE Cat 1 bis Module					
Model No.:	EG915Q-NA						
Trade Mark:	Quectel						
Hardware Version:	R1.0						
Software Version:	EG915QNALCR01A	A05M04	ļ				
INACI	RF Conducted	86750	7060015845				
IMEI:	RSE	RSE 867507060022437					
Antenna Type:	External Antenna						
	LTE Band 2:	1.43d	Bi	LTE Band 4:		1.54dBi	
	LTE Band 5: 2.21dBi		Bi	LTE Band 12	::	2.00dBi	
Antenna Gain:	LTE Band 13:	2.10d	Bi	LTE Band 66):	1.68dBi	
	Note: The antenna gain are derived from the gain information report provided by the manufacturer.					provided by the	
DE Cable:	0.8dB(Below 1GHz)		1.0dB(1.0~2.	4GHz)	1.2dB	(2.4~3.4GHz)	
RF Cable:	1.5dB(Above 3.4GF	lz)					
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3.5 Test Mode

Test Mode	Test Modes Description			
LTE/TM1	LTE system, QPSK modulation			
LTE/TM2	LTE system, 16QAM modulation			
Remark: The test mode(s) are selected according to relevant radio technology specifications.				

3.6 Test Environment

Environment Parameter	101.0 kPa Selected Values During Tests			
Relative Humidity 44-46 % RH Ambient				
Value	Temperature(°C)	Voltage(V)		
NTNV	22~23	3.8		
LTLV	-30	3.3		
LTHV	-30	4.3		
HTLV	50	3.3		
HTHV	50	4.3		
Remark:				
NV: Normal Voltage LV: I	.ow Extreme Test Voltage	HV: High Extreme Test Voltage		
NT: Normal Temperature LT: I	ow Extreme Test Temperature F	HT: High Extreme Test Temperature		

3.7 Description of Support Units

Description	Manufacturer	Model No.			
Mother board	Quectel	N/A			
Remark: all above the information of table are provided by client.					



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3.8 Technical Specification

Characteristics	Description						
Radio System Type	□ LTE						
	Band	TX RX					
	LTE Band 2	1850 to 1910 MHz 1930 to 1990 MHz					
	LTE Band 4	1710 to 1755 MHz 2110 to 2155 MHz					
Supported Frequency Range	LTE Band 5	824 to 849 MHz 869 to 894 MHz					
	LTE Band 12	699 to 716 MHz 729 to 746 MHz					
	LTE Band 13	777 to 787 MHz 746 to 756 MHz					
	LTE Band 66	1710 to 1780 MHz 2110 to 2200 MHz					
	LTE Band 2	⊠1.4 MHz ⊠3 MHz ⊠5 MHz ⊠10 MHz					
		⊠15 MHz ⊠20 MHz					
	LTE Band 4	□ 1.4 MHz □ 3 MHz □ 5 MHz □ 10 MHz					
		⊠15 MHz ⊠20 MHz					
Supported Channel Bandwidth	LTE Band 5	⊠1.4 MHz ⊠3 MHz ⊠5 MHz ⊠10 MHz					
	LTE Band 12	⊠1.4 MHz ⊠3 MHz ⊠5 MHz ⊠10 MHz					
	LTE Band 13	⊠5 MHz ⊠10 MHz					
	LTE Band 66	⊠1.4 MHz ⊠3 MHz ⊠5 MHz ⊠10 MHz					
		⊠15MHz ⊠20MHz					
	Note: Only 27 Resoumodulation is 16QAM	rce Blocks for 10MHz/15MHz/20MHz when the 1.					
Characteristics	Description						
	E-UTRA:	QPSK 16QAM					
		1M09G7D 1M10W7D					
Designation of Emissions		2M70G7D 2M69W7D					
(Remark: the necessary	LTE Band 2	4M47G7D 4M47W7D					
bandwidth of which is the	LTE Bana 2	8M94G7D 4M88W7D					
worst value from the		13M5G7D 5M23W7D					
measured occupied		18M0G7D 5M28W7D					
bandwidths for each type of		1M09G7D 1M10W7D					
channel bandwidth		2M70G7D 2M69W7D					
configuration.)	LTE Band 4	4M47G7D 4M47W7D					
		8M94G7D 4M88W7D					
		13M5G7D 5M23W7D					



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		i age	. 10 01 00
		18M0G7D	5M25W7D
	LTE Band 5	1M09G7D	1M10W7D
		2M70G7D	2M69W7D
		4M47G7D	4M47W7D
		8M95G7D	4M89W7D
		1M09G7D	1M10W7D
	LTE Dond 10	2M70G7D	2M69W7D
	LTE Band 12	4M47G7D	4M47W7D
		8M95G7D	4M89W7D
	LTE Band 13	4M47G7D	4M47W7D
		8M92G7D	4M89W7D
		1M09G7D	1M10W7D
		2M70G7D	2M69W7D
	LTE David CC	4M47G7D	4M47W7D
	LTE Band 66	8M95G7D	4M89W7D
		13M5G7D	5M22W7D
		18M0G7D	5M26W7D
		I	



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3.9 Test Frequencies

Toot Mode	Test Mode Bandwidth			RF Channel	
rest ivioue	Danuwiuin	TX / RX	Low (L)	Middle (M)	High (H)
	1.4MHz		Channel 18607	Channel 18900	Channel 19193
		TX	1850.7 MHz	1880 MHz	1909.3 MHz
		RX	Channel 607	Channel 900	Channel 1193
		KA.	1930.7 MHz	1960 MHz	1989.3 MHz
			Channel 18615	Channel 18900	Channel 19185
		TX	1851.5 MHz	1880 MHz	1908.5 MHz
	3MHz	DV	Channel 615	Channel 900	Channel 1185
		RX	1931.5 MHz	1960 MHz	1988.5 MHz
	5MHz	TX	Channel 18625	Channel 18900	Channel 19175
			1852.5 MHz	1880 MHz	1907.5 MHz
		RX	Channel 625	Channel 900	Channel1175
LTE Band 2			1932.5 MHz	1960 MHz	1987.5 MHz
LIE Dallu Z		10MHz RX	Channel 18650	Channel 18900	Channel 19150
			1855 MHz	1880 MHz	1905 MHz
	10MHz		Channel 650	Channel 900	Channel 1150
			1935 MHz	1960 MHz	1985 MHz
			Channel 18675	Channel 18900	Channel 19125
		TX	1857.5 MHz	1880 MHz	1902.5 MHz
	15MHz	RX	Channel 675	Channel 900	Channel 1125
		KA.	1937.5 MHz	1960 MHz	1982.5 MHz
			Channel 18700	Channel 18900	Channel 19100
		TX	1860 MHz	1880 MHz	1900 MHz
	20MHz RX	DV	Channel 700	Channel 900	Channel 1100
		1940 MHz	1960 MHz	1980 MHz	



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			raye.	17 01 33	
Test Mode	Bandwidth	TX / RX		RF Channel	
i est ivioue	Dandwidth	IX/IX	Low (L)	Middle (M)	High (H)
	1.4MHz		Channel 19957	Channel 20175	Channel 20393
		TX	1710.7 MHz	1732.5 MHz	1754.3 MHz
		RX	Channel 1975	Channel 2175	Channel 2375
		KA	2112.5 MHz	2132.5MHz	2152.5 MHz
			Channel 19965	Channel 20175	Channel 20385
		TX	1711.5 MHz	1732.5 MHz	1753.5 MHz
	3MHz	RX	Channel 2000	Channel 2175	Channel 2350
	KA.	2115 MHz	2132.5MHz	2150 MHz	
	5MHz	TX	Channel 19975	Channel 20175	Channel 20375
			1712.5 MHz	1732.5 MHz	1752.5 MHz
		RX	Channel 1975	Channel 2175	Channel 2375
LTC Dand 4			2112.5 MHz	2132.5MHz	2152.5 MHz
LTE Band 4		TX	Channel 20000	Channel 20175	Channel 20350
			1715 MHz	1732.5 MHz	1750 MHz
	10MHz	RX	Channel 2000	Channel 2175	Channel 2350
		KA.	2115 MHz	2132.5MHz	2150 MHz
		TX	Channel 20025	Channel 20175	Channel 20325
			1717.5 MHz	1732.5 MHz	1747.5 MHz
	15MHz	RX	Channel 2025	Channel 2175	Channel 2325
_			2117.5 MHz	2132.5MHz	2147.5 MHz
			Channel 20050	Channel 20175	Channel 20300
		TX	1720 MHz	1732.5 MHz	1745 MHz
	20MHz	DV	Channel 2050	Channel 2175	Channel 2300
		RX	2120 MHz	2132.5MHz	2145 MHz

Took Made	Donduidth	TV / DV	RF Channel		
Test Mode	Bandwidth	TX / RX	Low (L)	Middle (M)	High (H)
			Channel 20407	Channel 20525	Channel 20643
		TX	824.7 MHz	836.5 MHz	848.3 MHz
	1.4MHz	RX	Channel 2407	Channel 2525	Channel 2643
		KA.	869.7 MHz	881.5 MHz	893.3 MHz
			Channel 20415	Channel 20525	Channel 20635
	3MHz	TX	825.5 MHz	836.5 MHz	847.5 MHz
		RX	Channel 2415	Channel 2525	Channel 2635
1.TE D 1.5			870.5 MHz	881.5 MHz	892.5 MHz
LTE Band 5	5141	TX	Channel 20425	Channel 20525	Channel 20625
			826.5 MHz	836.5 MHz	846.5 MHz
	5MHz	RX	Channel 2425	Channel 2525	Channel 2625
		KA.	871.5 MHz	881.5 MHz	891.5 MHz
			Channel 20450	Channel 20525	Channel 20600
		10MHz	829 MHz	836.5 MHz	844 MHz
	10MHz		Channel 2450	Channel 2525	Channel 2600
		RX		881.5 MHz	889 MHz



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			ı ayc.	10 01 33		
Test Mode	Bandwidth	TX / RX		RF Channel		
rest Mode	Dandwidth	IA/RA	Low (L)	Middle (M)	High (H)	
			Channel 23017	Channel 23095	Channel 23173	
		TX	699.7 MHz	707.5 MHz	715.3 MHz	
	1.4MHz	RX	Channel 5017	Channel 5095	Channel 5173	
		Γ.Λ	729.7 MHz	737.5 MHz	745.3 MHz	
			Channel 23025	Channel 23095	Channel 23165	
	3MHz	TX	700.5 MHz	707.5 MHz	714.5 MHz	
		RX	Channel 5025	Channel 5095	Channel 5165	
LTE Day 140			730.5 MHz	737.5 MHz	744.5 MHz	
LTE Band 12	51411	тх	Channel 23035	Channel 23095	Channel 23155	
			701.5 MHz	707.5 MHz	713.5 MHz	
	5MHz	RX	Channel 5035	Channel 5095	Channel 5155	
		KA	731.5 MHz	737.5 MHz	743.5 MHz	
			Channel 23060	Channel 23095	Channel 23130	
		TX	704 MHz	707.5 MHz	711 MHz	
	10MHz	10MHz	Channel 5060	Channel 5095	Channel 5130	
		RX		734 MHz	737.5 MHz	741 MHz

Test Mode Bandwidth		TX / RX	RF Channel		
rest ivioue	viode Baridwidth	IA/KA	Low (L)	Middle (M)	High (H)
			Channel 23025	Channel 23230	Channel 23255
		TX	779.5 MHz	782 MHz	784.5 MHz
LTE Danid 40	LTE Band 13 TX 10MHz	RX	Channel 5205	Channel 5230	Channel 5255
			748.5 MHz	751 MHz	753.5 MHz
LIE Ballu 13		TX	Channel 23230	Channel 23230	Channel 23230
			782 MHz	782 MHz	782 MHz
		DV	Channel 5230	Channel 5230	Channel 5230
		RX	751 MHz	751 MHz	751 MHz



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			raye.	19 01 33	
Test Mode	Bandwidth	TX / RX	, RF Channel		
1 CSt Would	Danuwidin	IX/IX	Low (L)	Middle (M)	High (H)
	1.4MHz	-,,	Channel 131979	Channel 132322	Channel 132665
		TX	1710.7 MHz	1745 MHz	1779.3 MHz
		RX	Channel 66443	Channel 66786	Channel 67329
			2110.7 MHz	2145MHz	2199.3 MHz
		TX	Channel 131987	Channel 132322	Channel 132657
			1711.5 MHz	1745 MHz	1778.5MHz
	3MHz	RX	Channel 66451	Channel 66786	Channel 67321
		KA .	2111.5 MHz	2145MHz	2198.5MHz
		TX	Channel 131997	Channel 132322	Channel 132647
	5MHz		1712.5 MHz	1745 MHz	1777.5 MHz
LTE D 100		RX	Channel 66461	Channel 66786	Channel 67311
			2112.5 MHz	2145MHz	2197.5 MHz
LTE Band66		TX	Channel 132022	Channel 132322	Channel 132622
			1715 MHz	1745 MHz	1775 MHz
	10MHz	RX	Channel 66486	Channel 66786	Channel 67286
			2115 MHz	2145MHz	2195 MHz
	15MHz	TX	Channel 132047	Channel 132322	Channel 132597
			1717.5 MHz	1745 MHz	1772.5 MHz
-		RX	Channel 66511	Channel 66786	Channel 67261
			2117.5 MHz	2145MHz	2192.5 MHz
		TX	Channel 132072	Channel 132322	Channel 132572
			1720 MHz	1745 MHz	1770 MHz
	20MHz	DV	Channel 66536	Channel 66786	Channel 67236
		RX	2120 MHz	2145MHz	2190 MHz



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4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.2.1

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Remark: Reference test setup 1



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4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8.4

Calculate power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB



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4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2 & 4.3

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel). The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

Test Settings

- The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- 3. VBW ≥ 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2 7 were repeated after changing the RBW such that it would be within
 - 1 5% of the 99% occupied bandwidth observed in Step 7



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4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to rms.

Remark: Reference test setup 1

Test Settings

- 1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
- 2. Span was set large enough so as to capture all out of band emissions near the band edge
- 3. RBW > 1% of the emission bandwidth
- VBW > 3 x RBW
- Detector = RMS
- Number of sweep points ≥ 2 x Span/RBW
- 7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 8. Sweep time = auto couple
- 9. The trace was allowed to stabilize





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4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel). The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

- 1. Start frequency was set to 9kHz and stop frequency was set to at least 10* the fundamental frequency(Separated into at least two plots per channel)
- 2. Detector = RMS
- 3. Trace mode = trace average for continuous emissinos, max hold for pulse emissions
- 4. Sweep time = auto couple
- 5. The trace was allowed to stabilize
- 6. Please see test notes below for RBW and VBW settings



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4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.2

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Remark: Reference test setup 1

Test Settings

- 1. The signal analyzer's CCDF measurement profile is enabled
- Frequency = carrier center frequency
- Measurement BW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power



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4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8

Below 1GHz test procedure as below:

- 1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.
- 2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 4). Test the EUT in the lowest channel, the middle channel ,the Highest channel.
- 5). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 6). Repeat above procedures until all frequencies measured was complete.

E (dB μ V/m) = Measured amplitude level (dB μ V) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB)) EIRP (dBm) = E (dB μ V/m) + 20 log D – 104.8; where D is the measurement distance in meters

Above 1GHz test procedure as below:

- Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber
- 2) Calculate power in dBm by the following formula:

E (dB μ V/m) = Measured amplitude level (dB μ V) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB)) EIRP (dBm) = E (dB μ V/m) + 20 log D – 104.8; where D is the measurement distance in meters

- 3). Test the EUT in the lowest channel, the middle channel the Highest channel
- 4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.
- 5). Repeat above procedures until all frequencies measured was complete

Remark1: Reference test setup 2

Remark2: The emission below 18G were measured at a 3m test distance, while emissions above 18GHz were measured at a 1m test distance. At a measurement distance of 1 meter the limit line was increased by 20*LOG(3/1) = 9.54 dB.

Remark: Reference test setup 2

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & AMP. The basic equation with a sample calculation is as follows:

AF = Antenna Factor(dB/m)

Factor = Cable Factor(dB) - Preamplifier (dB)

Level = Reading Level + AF + Factor -95.26

Margin = Limit - Level

2) Scan from 9kHz to 40GHz, The disturbance between 9KHz to 30MHz and 18GHz to 40GHz was very low, and the harmonics were the highest point could be found when testing, so only the harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3) All modes have been tested, but only the worst case data displayed in this report.



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4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; Section 9

- . The frequency stability of the transmitter is measured by:
- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Time Period and Procedure:

- The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 3



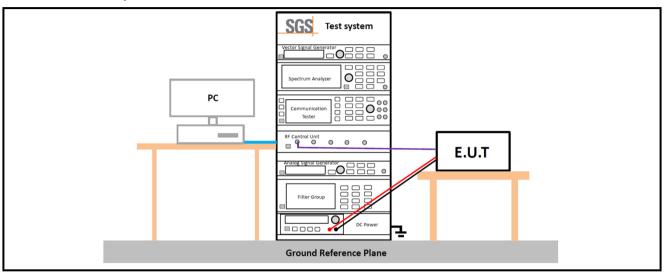


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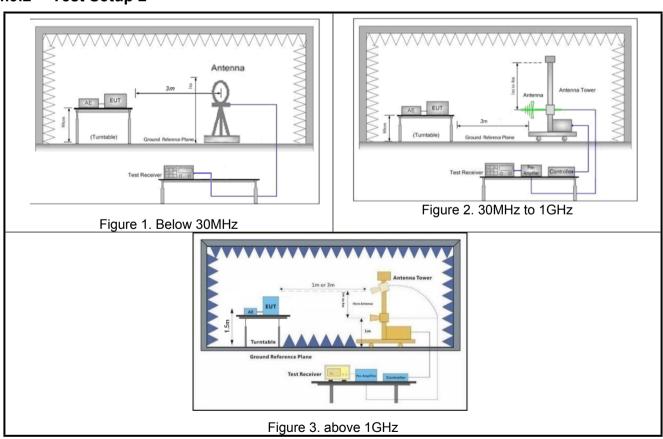
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4.9 Test Setups

4.9.1 Test Setup 1



4.9.2 Test Setup 2





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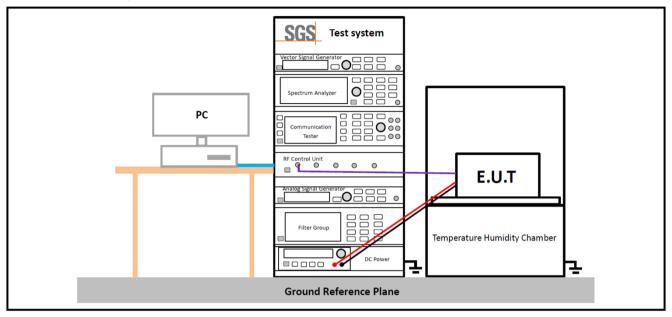


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4.9.3 Test Setup 3





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4.10Test Conditions

Transmit Output Power Data - Average Power, Total			
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1;LTE/TM2		
	Peak-to-Average Ratio		
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1		
	Modulation Characteristics		
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	M (M= middle channel)		
Test Mode	LTE/TM1;LTE/TM2		
	Bandwidth - Occupied Bandwidth		
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1;LTE/TM2		
Bandwidth - Emission Bandwidth			
Test Case	Test Conditions		
Test Environment	Ambient Climate & Rated Voltage		
Test Setup	Test Setup 1		
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)		
Test Mode	LTE/TM1;LTE/TM2		
Band Edges Compliance			
Test Case	Test Conditions		



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	1 agc. 01 01 00			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, H (L= low channel, H= high channel)			
Test Mode	LTE/TM1			
	Spurious Emission at Antenna Terminals			
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 1			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1			
Field Strength of Spurious Radiation				
Test Case	Test Conditions			
Test Environment	Ambient Climate & Rated Voltage			
Test Setup	Test Setup 2			
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)			
Test Mode	LTE/TM1 Remark: All bandwidth and modulation of LTE have been pre tested, and only the worst results are reflected in the report.			
Frequency Stability				
Test Case	Test Conditions			
Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage			
rest Environment	(2) VL, VN and VH of Rated Voltage at Ambient Climate.			
Test Setup	Test Setup 3			
RF Channels (TX)	M (M= middle channel)			
Test Mode	LTE/TM1			



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Main Test Instruments 5

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
Shielding Room	Brilliant-emc	N/A	SUWI-04-01-06	2021/05/08	2024/05/07
Temperature and humidity meter	MingGao	TH101B	SUWI-01-01-07	2023/02/06	2024/02/05
Signal Analyzer	ROHDE&SCHWARZ	FSV3030	SUWI-01-02-02	2022/05/17	2023/05/16
Measurement Software	Tonscend	JS1120-3 Test System V 2.6.88.0336	SUWI-02-09-09	NCR	NCR
Radio Communication Analyzer	Anritsu	MT8821C	SUWI-01-26-03	2022/11/23	2023/11/22
Wideband Radio Communication Tester	ROHDE&SCHWARZ	CMW500	SUWI-01-16-05	2023/02/06	2024/02/05
DC Power Supply	HYELEC	HY3005B	SUWI-01-18-01	2023/02/06	2024/02/05
Temperature Chamber	ESPEC	SU-242	SUWI-01-13-01	2023/02/06	2024/02/05
Wideband Radio Communication Test Ststion	Anritsu	MT8000A	SUWI-01-34-02	2022/09/16	2023/09/15
Signal Analyzer	ROHDE&SCHWARZ	FSW43	SUWI-01-02-04	2022/05/28	2023/05/27



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	RSE Test System				
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy/mm/dd)	Cal.Due date (yyyy/mm/dd)
Semi-Anechoic Chamber	Brilliant-emc	N/A	SUWI-04-02-01	2021/05/08	2024/05/07
Temperature and humidity meter	MingGao	TH101B	SUWI-01-01-05	2023/02/07	2024/02/06
Signal Analyzer	ROHDE&SCHWARZ	FSW43	SUWI-01-02-04	2022/05/28	2023/05/27
Signal Analyzer	KEYSIGHT	N9020A	SUWI-01-02-05	2022/11/23	2023/11/22
Test receiver	ROHDE&SCHWARZ	ESR7	SUWI-01-10-01	2023/02/08	2024/02/07
Receiving antenna	SCHWRZBECK MESS- ELEKTRONIK	VULB 9163	SUWI-01-11-01	2021/05/16	2023/05/15
Receiving antenna	SCHWRZBECK MESS- ELEKTRONIK	BBHA 9120D	SUWI-01-11-02	2021/05/16	2023/05/15
Receiving antenna	SCHWRZBECK MESS- ELEKTRONIK	BBHA 9170	SUWI-01-11-03	2021/05/14	2023/05/13
Amplifier	Tonscend	TAP9K3G40	SUWI-01-14-01	2023/02/06	2024/02/05
Amplifier	Tonscend	TAP01018050	SUWI-01-14-02	2023/02/06	2024/02/05
Amplifier	Tonscend	TAP18040048	SUWI-01-14-03	2023/02/08	2024/02/07
Active Loop Antenna	SCHWRZBECK MESS- ELEKTRONIK	FMZB 1519B	SUWI-01-21-01	2021/06/10	2023/06/09
Radio Communication Analyzer	Anritsu	MT8821C	SUWI-01-26-03	2022/11/23	2023/11/22
Measurement Software	Tonscend	JS32-RE 4.0.0.0	SUWI-02-09-04	NCR	NCR



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6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

No.	Item Measurement Uncertainty	
1	Total RF power, conducted	±0.54dB
2	RF power density, conducted	±1.03dB
3	Spurious emissions, conducted	±0.54dB
4	Radio Frequency	±1.0 %
5	Duty Cycle	±0.37%
6	Occupied Bandwidth	±1.0 %
		± 3.13dB (9k -30MHz)
7	Redicted Emission	± 4.80dB (30M -1GHz)
7	Radiated Emission	± 4.80dB (1GHz to 18GHz)
		± 4.80dB (Above 18GHz)

Remark:

The U_{lab} (lab Uncertainty) is less than $U_{\text{cispr/ETSI}}$ (CISPR/ETSI Uncertainty), so the test results

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;

- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.



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7 Appendixes

Appendix A.2	WWAN Setup Photos
Appendix B.1	LTE Band 2
Appendix B.2	LTE Band 4
Appendix B.3	LTE Band 5
Appendix B.4	LTE Band 12
Appendix B.5	LTE Band 13
Appendix B.6	LTE Band 66

---End of Report---



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